## Application/Control No. Applicant(s)/Patent Under Reexamination 10/667,671 TAKEI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Marc S. Zimmer 1712 **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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